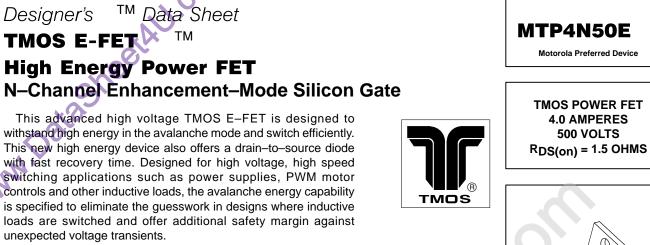
Designer's

Motorola Preferred Device

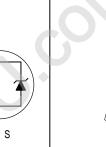
4.0 AMPERES

**500 VOLTS** 



- Avalanche Energy Capability Specified at Elevated Temperature
- Low Stored Gate Charge for Efficient Switching
- Internal Source-to-Drain Diode Designed to Replace External Zener Transient Suppressor — Absorbs High Energy in the Avalanche Mode
- Source-to-Drain Diode Recovery Time Comparable to Discrete Fast Recovery Diode





CASE 221A-06, Style 5 TO-220AB

#### **MAXIMUM RATINGS** (T<sub>C</sub> = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain–Source Voltage	V <sub>DSS</sub>	500	Vdc
Drain–Gate Voltage ( $R_{GS} = 1.0 M\Omega$ )	V <sub>DGR</sub>	500	Vdc
Gate–Source Voltage — Continuous — Non–repetitive	V <sub>GS</sub> V <sub>GSM</sub>	±20 ±40	Vdc Vpk
Drain Current — Continuous — Pulsed	I <sub>D</sub> I <sub>DM</sub>	4.0 10	Adc
Total Power Dissipation @ T <sub>C</sub> = 25°C Derate above 25°C	PD	75 0.6	Watts W/°C
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to 150	°C

#### UNCLAMPED DRAIN-TO-SOURCE AVALANCHE CHARACTERISTICS (T.I < 150°C)

	/		
Single Pulse Drain-to-Source Avalanche Energy — TJ = 25°C	W <sub>DSR</sub> (1)	280	mJ
$- T_{J} = 100^{\circ}C$	-	44	
Repetitive Pulse Drain-to-Source Avalanche Energy	W <sub>DSR</sub> (2)	7.4	
THERMAL CHARACTERISTICS			
Thermal Resistance — Junction to Case	R <sub>θJC</sub>	1.67	°C/W
— Junction to Ambient	$R_{\theta JA}$	62.5	
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	т	260	°C

(1)  $V_{DD} = 50 \text{ V}, I_D = 4.0 \text{ A}$ 

(2) Pulse Width and frequency is limited by T<sub>J</sub>(max) and thermal response

Designer's Data for "Worst Case" Conditions - The Designer's Data Sheet permits the design of most circuits entirely from the information presented. SOA Limit curves — representing boundaries on device characteristics — are given to facilitate "worst case" design.

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Preferred devices are Motorola recommended choices for future use and best overall value

**REV 1** 

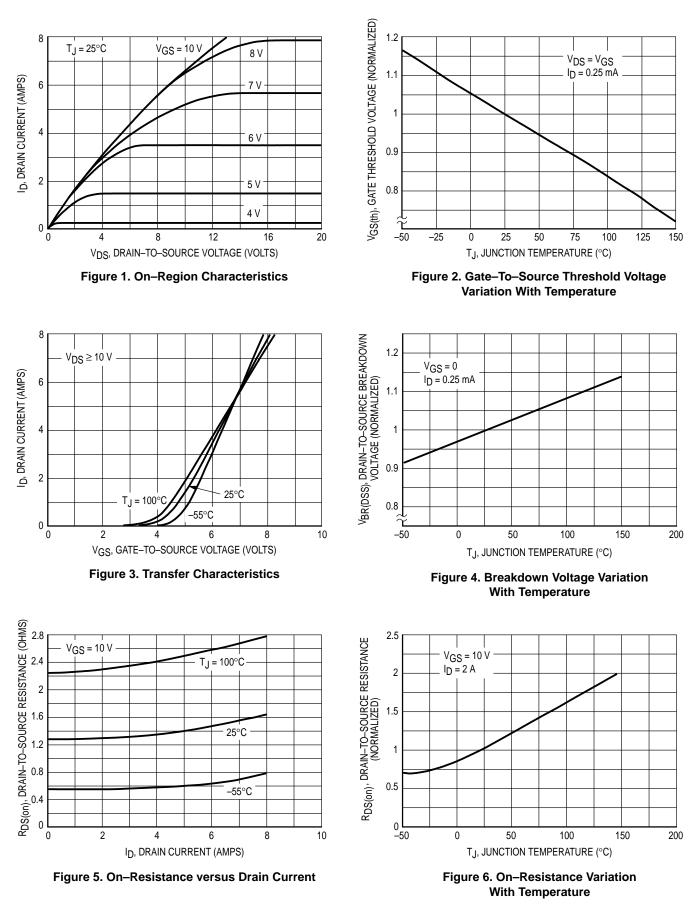
#### MTP4N50E

ELECTRICAL CHARACTERISTICS (T = 25°C unless otherwise noted)

Characteristic		Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain–to–Source Breakdown Voltage ( $V_{GS} = 0$ , $I_D = 250 \mu Adc$ )		V(BR)DSS	500	—	_	Vdc
Zero Gate Voltage Drain Current ( $V_{DS} = 500 \text{ V}, V_{GS} = 0$ ) ( $V_{DS} = 400 \text{ V}, V_{GS} = 0, T_J = 125$	°C)	IDSS			0.25 1.0	mAdc
Gate-Body Leakage Current, Forw	ard (V <sub>GSF</sub> = 20 Vdc, $V_{DS}$ = 0)	IGSSF	_	—	100	nAdc
Gate-Body Leakage Current, Reve	rse ( $V_{GSR}$ = 20 Vdc, $V_{DS}$ = 0)	IGSSR	_	—	100	nAdc
ON CHARACTERISTICS*						
Gate Threshold Voltage $(V_{DS} = V_{GS}, I_D = 250 \mu\text{Adc})$ $(T_J = 125^{\circ}\text{C})$		V <sub>GS(th)</sub>	2.0 1.5		4.0 3.5	Vdc
Static Drain–Source On–Resistance	$(V_{GS} = 10 \text{ Vdc}, I_D = 2.0 \text{ A})$	R <sub>DS(on)</sub>		1.3	1.5	Ohm
Drain–Source On–Voltage (V <sub>GS</sub> = 10 Vdc) (I <sub>D</sub> = 4.0 Adc) (I <sub>D</sub> = 2.0 A, T <sub>J</sub> = 100°C)		VDS(on)			7.5 6.0	Vdc
Forward Transconductance (V <sub>DS</sub> =	15 Vdc, I <sub>D</sub> = 2.0 A)	9FS	1.5	—	—	mhos
DYNAMIC CHARACTERISTICS		•				
Input Capacitance		C <sub>iss</sub>	—	775	—	pF
Output Capacitance	(V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0, f = 1.0 MHz)	C <sub>oss</sub>	_	84	—	
Transfer Capacitance		C <sub>rss</sub>	_	19	—	
SWITCHING CHARACTERISTICS*						
Turn-On Delay Time		<sup>t</sup> d(on)		24	—	ns
Rise Time	$(V_{DD} = 250 \text{ V}, \text{ I}_{D} \approx 4.0 \text{ A}, \text{ R}_{G} = 12 \Omega, \text{ R}_{L} = 62 \Omega,$	tr		34	—	
Turn–Off Delay Time	$V_{GS(on)} = 10 V$	<sup>t</sup> d(off)		60	—	-
Fall Time		t <sub>f</sub>	—	36	—	
Total Gate Charge		Qg	_	27	32	nC
Gate-Source Charge	(V <sub>DS</sub> = 400 V, I <sub>D</sub> = 4.0 A, V <sub>GS</sub> = 10 V)	Qgs	_	3.5	—	
Gate-Drain Charge		Q <sub>gd</sub>	_	14	—	
SOURCE-DRAIN DIODE CHARACT	ERISTICS					
Forward On–Voltage		V <sub>SD</sub>	_	—	1.4	Vdc
Forward Turn–On Time	$(I_{S} = 4.0 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s})$	ton		**	_	ns
Reverse Recovery Time		t <sub>rr</sub>	_	—	760	
NTERNAL PACKAGE INDUCTANCI						
Internal Drain Inductance (Measured from the contact screw (Measured from the drain lead 0.2		Ld		3.5 4.5		nH
Internal Source Inductance (Measured from the source lead 0	.25" from package to source bond pad)	L <sub>S</sub>	_	7.5	—	1

\* Indicates Pulse Test: Pulse Width = 300  $\mu s$  Max, Duty Cycle  $\leq$  2.0%. \*\* Limited by circuit inductance.

# **TYPICAL ELECTRICAL CHARACTERISTICS**



### SAFE OPERATING AREA INFORMATION

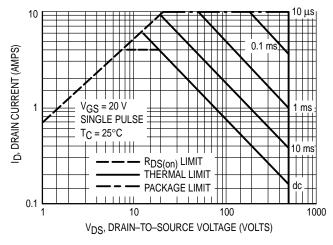


Figure 7. Maximum Rated Forward Biased Safe Operating Area

## FORWARD BIASED SAFE OPERATING AREA

The FBSOA curves define the maximum drain-to-source voltage and drain current that a device can safely handle when it is forward biased, or when it is on, or being turned on. Because these curves include the limitations of simultaneous high voltage and high current, up to the rating of the device, they are especially useful to designers of linear systems. The curves are based on a case temperature of 25°C and a maximum junction temperature of 150°C. Limitations for repetitive pulses at various case temperatures can be determined by using the thermal response curves. Motorola Application Note, AN569, "Transient Thermal Resistance–General Data and Its Use" provides detailed instructions.

#### SWITCHING SAFE OPERATING AREA

The switching safe operating area (SOA) of Figure 8 is the boundary that the load line may traverse without incurring damage to the MOSFET. The fundamental limits are the peak current, IDM and the breakdown voltage, V(BR)DSS. The switching SOA shown in Figure 8 is applicable for both turn-on and turn-off of the devices for switching times less than one microsecond.

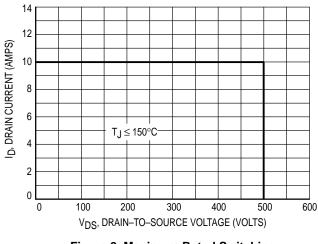


Figure 8. Maximum Rated Switching Safe Operating Area

The power averaged over a complete switching cycle must be less than:

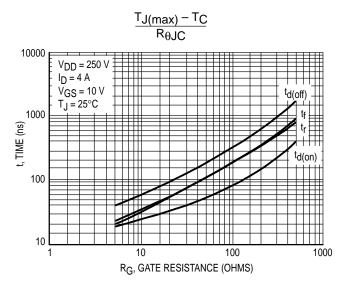


Figure 9. Resistive Switching Time Variation versus Gate Resistance

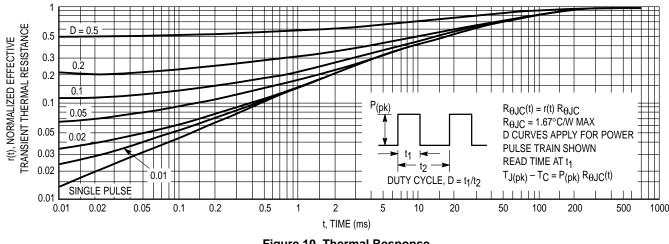
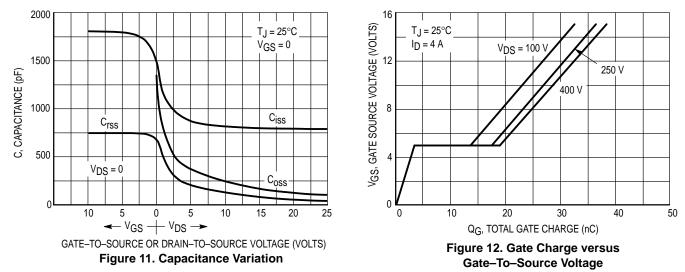


Figure 10. Thermal Response



**COMMUTATING SAFE OPERATING AREA (CSOA)** 

The Commutating Safe Operating Area (CSOA) of Figure 14 defines the limits of safe operation for commutated source–drain current versus re–applied drain voltage when the source–drain diode has undergone forward bias. The curve shows the limitations of  $I_{FM}$  and peak  $V_{DS}$  for a given rate of change of source current. It is applicable when waveforms similar to those of Figure 13 are present. Full or half–bridge PWM DC motor controllers are common applications requiring CSOA data.

Device stresses increase with increasing rate of change of source current so dl<sub>S</sub>/dt is specified with a maximum value. Higher values of dl<sub>S</sub>/dt require an appropriate derating of I<sub>FM</sub>, peak V<sub>DS</sub> or both. Ultimately dl<sub>S</sub>/dt is limited primarily by device, package, and circuit impedances. Maximum device stress occurs during t<sub>rr</sub> as the diode goes from conduction to reverse blocking.

 $V_{DS(pk)}$  is the peak drain–to–source voltage that the device must sustain during commutation;  $I_{FM}$  is the maximum forward source–drain diode current just prior to the onset of commutation.

 $V_R$  is specified at 80% of  $V_{(BR)DSS}$  to ensure that the CSOA stress is maximized as  $I_S$  decays from  $I_{RM}$  to zero.

RGS should be minimized during commutation. TJ has only a second order effect on CSOA.

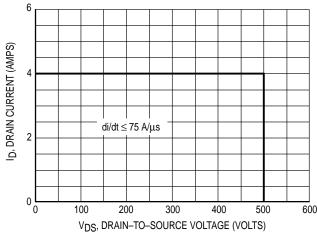


Figure 13. Commutating Safe Operating Area (CSOA)

Stray inductances in Motorola's test circuit are assumed to be practical minimums.  $dV_{DS}/dt$  in excess of 10 V/ns was attained with  $dI_S/dt$  of 400 A/µs.

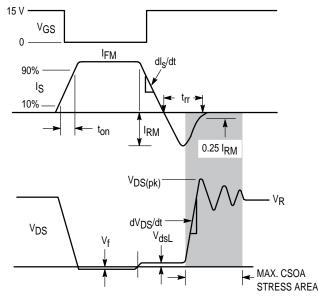


Figure 15. Commutating Waveforms

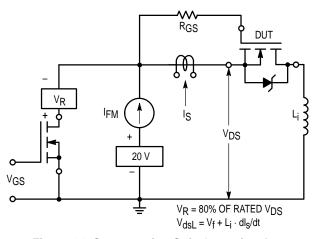


Figure 14. Commutating Safe Operating Area Test Circuit

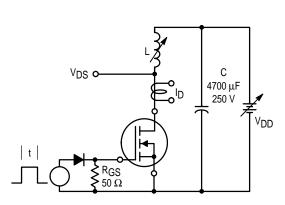


Figure 16. Unclamped Inductive Switching Test Circuit

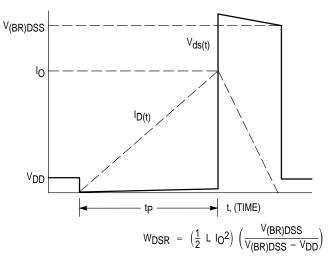
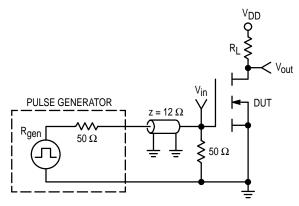
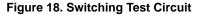


Figure 17. Unclamped Inductive Switching Waveforms



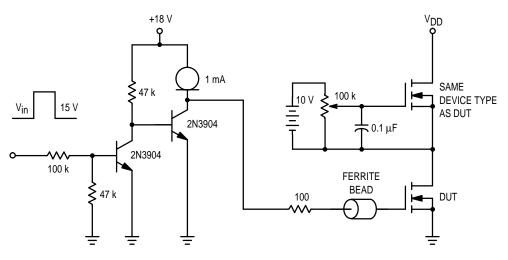


\* Note: The Mirror is shorted to the Kelvin terminal for this test.

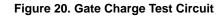


tont∩fl td(off) td(on) t, 90% 90% OUTPUT, Vout INVERTED 10% 90% 50% 50% INPUT, V<sub>in</sub> 10% PULSE WIDTH

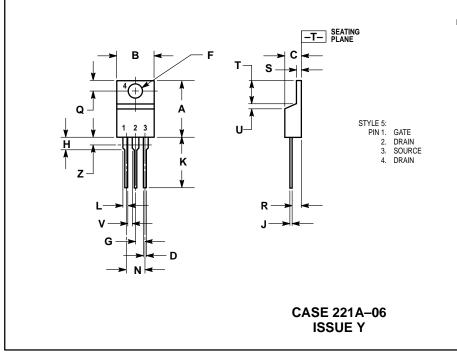
Figure 19. Switching Waveforms



 $V_{in}$  = 15  $V_{pk};$  PULSE WIDTH  $\leq$  100  $\mu s,$  DUTY CYCLE  $\leq$  10%



## PACKAGE DIMENSIONS



- NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH. 3. DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.570	0.620	14.48	15.75
в	0.380	0.405	9.66	10.28
c	0.160	0.190	4.07	4.82
D	0.025	0.035	0.64	0.88
F	0.142	0.147	3.61	3.73
Ð	0.095	0.105	2.42	2.66
Η	0.110	0.155	2.80	3.93
L	0.018	0.025	0.46	0.64
Κ	0.500	0.562	12.70	14.27
Г	0.045	0.060	1.15	1.52
N	0.190	0.210	4.83	5.33
Q	0.100	0.120	2.54	3.04
R	0.080	0.110	2.04	2.79
S	0.045	0.055	1.15	1.39
Т	0.235	0.255	5.97	6.47
U	0.000	0.050	0.00	1.27
۷	0.045		1.15	
Ζ		0.080		2.04

MTP4N50E

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